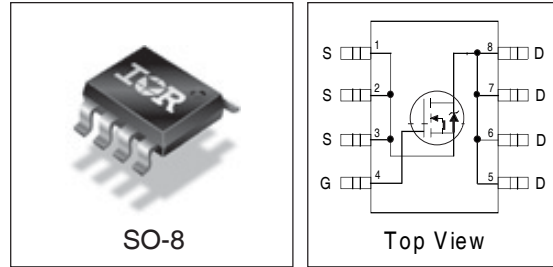# International IƏR Rectifier

IRF7807VPbF

• N Channel Application Specific MOSFET
• Ideal for Mobile DC-DC Converters
• Low Conduction Losses
• Low Switching Losses
• 100% R_G Tested
• Lead-Free

HEXFET® Power MOSFET

SO-8

Top View

DEVICE CHARACTERISTICS⑤

	IRF7807V
$R_{DS(on)}$	17 mΩ
Q_G	9.5 nC
Q_{SW}	3.4 nC
Q_{OSS}	12 nC

Description

This new device employs advanced HEXFET Power MOSFET technology to achieve an unprecedented balance of on-resistance and gate charge. The reduction of conduction and switching losses makes it ideal for high efficiency DC-DC Converters that power the latest generation of mobile microprocessors.

A pair of IRF7807V devices provides the best cost/performance solution for system voltages, such as 3.3V and 5V.

Absolute Maximum Ratings

Parameter		Symbol	IRF7807V	Units
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±20	
Continuous Drain or Source	$T_A = 25°C$	I_D	8.3	A
($V_{GS} \geq 4.5V$)	$T_A = 70°C$		6.6	
Pulsed Drain Current ①		I_{DM}	66	
Power Dissipation ③	$T_A = 25°C$	P_D	2.5	W
	$T_A = 70°C$		1.6	
Junction & Storage Temperature Range		T_J , T_{STG}	-55 to 150	°C
Continuous Source Current (Body Diode)		I_S	2.5	A
Pulsed Source Current ①		I_{SM}	66	

Thermal Resistance

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ③ ⑥	$R_{\theta JA}$	——	50	°C/W
Maximum Junction-to-Lead ⑥	$R_{\theta JL}$	——	20	

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Electrical Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	30	——	——	V	$V_{GS} = 0V$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	$R_{DS(on)}$	——	17	25	mΩ	$V_{GS} = 4.5V$, $I_D = 7.0A$ ②
Gate Threshold Voltage	$V_{GS(th)}$	1.0	——	3.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Drain-Source Leakage Current	I_{DSS}	——	——	100	µA	$V_{DS} = 30V$, $V_{GS} = 0$
		——	——	20		$V_{DS} = 24V$, $V_{GS} = 0$
		——	——	100		$V_{DS} = 24V$, $V_{GS} = 0$, $T_J = 100°C$
Gate-Source Leakage Current*	I_{GSS}	——	——	±100	nA	$V_{GS} = \pm 20V$
Total Gate Charge*	Q_G	——	9.5	14	nC	$V_{GS} = 5V$, $I_D = 7.0A$ $V_{DS} = 16V$
Pre-Vth Gate-Source Charge	Q_{GS1}	——	2.3	——		
Post-Vth Gate-Source Charge	Q_{GS2}	——	1.0	——		
Gate-to-Drain Charge	Q_{GD}	——	2.4	——		
Switch Charge ($Q_{gs2} + Q_{gd}$)	Q_{SW}	——	3.4	5.2		
Output Charge*	Q_{OSS}	——	12	16.8		$V_{DS} = 16V$, $V_{GS} = 0$
Gate Resistance	R_G	0.9	——	2.8	Ω	
Turn-On Delay Time	$t_{d(on)}$	——	6.3	——	ns	$V_{DD} = 16V$ $I_D = 7A$ $V_{GS} = 5V$, $R_G = 2\Omega$ Resistive Load
Rise Time	t_r	——	1.2	——		
Turn-Off Delay Time	$t_{d(off)}$	——	11	——		
Fall Time	t_f	——	2.2	——		

Source-Drain Ratings and Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Conditions
Diode Forward Voltage*	V_{SD}	——	——	1.2	V	$I_S = 7.0A$ ② , $V_{GS} = 0V$
Reverse Recovery Charge ④	Q_{rr}	——	64	——	nC	di/dt = 700A/µs $V_{DS} = 16V$, $V_{GS} = 0V$, $I_S = 7.0A$
Reverse Recovery Charge (with Parallel Schottsky) ④	$Q_{rr(s)}$	——	41	——		di/dt = 700A/µs , (with 10BQ040) $V_{DS} = 16V$, $V_{GS} = 0V$, $I_S = 7.0A$

Notes:
① Repetitive rating; pulse width limited by max. junction temperature.
② Pulse width ≤ 400 µs; duty cycle ≤ 2%.
③ When mounted on 1 inch square copper board
④ Typ = measured - Q_{oss}
⑤ Typical values of $R_{DS}(on)$ measured at $V_{GS} = 4.5V$, Q_G, Q_{SW} and Q_{OSS}
   measured at $V_{GS} = 5.0V$, $I_F = 7.0A$.
⑥ R_θ is measured at T_J approximately **90°C**

* Device are 100% tested to these parameters.

Power MOSFET Selection for DC/DC Converters

Control FET

Special attention has been given to the power losses in the switching elements of the circuit - Q1 and Q2. Power losses in the high side switch Q1, also called the Control FET, are impacted by the $R_{ds(on)}$ of the MOSFET, but these conduction losses are only about one half of the total losses.

Power losses in the control switch Q1 are given by;

$$P_{loss} = P_{conduction} + P_{switching} + P_{drive} + P_{output}$$

This can be expanded and approximated by;

$$P_{loss} = \left(I_{rms}{}^2 \times R_{ds(on)} \right)$$
$$+ \left(I \times \frac{Q_{gd}}{i_g} \times V_{in} \times f \right) + \left(I \times \frac{Q_{gs2}}{i_g} \times V_{in} \times f \right)$$
$$+ \left(Q_g \times V_g \times f \right)$$
$$+ \left(\frac{Q_{oss}}{2} \times V_{in} \times f \right)$$

This simplified loss equation includes the terms Q_{gs2} and Q_{oss} which are new to Power MOSFET data sheets.

Q_{gs2} is a sub element of traditional gate-source charge that is included in all MOSFET data sheets. The importance of splitting this gate-source charge into two sub elements, Q_{gs1} and Q_{gs2}, can be seen from Fig 1.

Q_{gs2} indicates the charge that must be supplied by the gate driver between the time that the threshold voltage has been reached (t1) and the time the drain current rises to I_{dmax} (t2) at which time the drain voltage begins to change. Minimizing Q_{gs2} is a critical factor in reducing switching losses in Q1.

Q_{oss} is the charge that must be supplied to the output capacitance of the MOSFET during every switching cycle. Figure 2 shows how Q_{oss} is formed by the parallel combination of the voltage dependant (non-linear) capacitance's C_{ds} and C_{dg} when multiplied by the power supply input buss voltage.
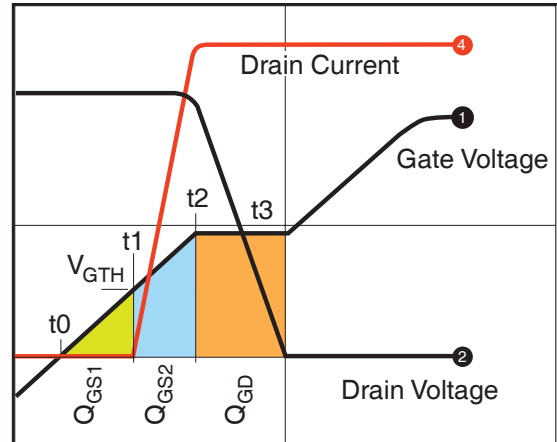

Figure 1: Typical MOSFET switching waveform

Synchronous FET

The power loss equation for Q2 is approximated by;

$$P_{loss} = P_{conduction} + P_{drive} + P_{output}^*$$
$$P_{loss} = \left(I_{rms}{}^2 \times R_{ds(on)} \right)$$
$$+ \left(Q_g \times V_g \times f \right)$$
$$+ \left(\frac{Q_{oss}}{2} \times V_{in} \times f \right) + \left(Q_{rr} \times V_{in} \times f \right)$$

*dissipated primarily in Q1.

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IRF7807VPbF

For the synchronous MOSFET Q2, $R_{ds(on)}$ is an important characteristic; however, once again the importance of gate charge must not be overlooked since it impacts three critical areas. Under light load the MOSFET must still be turned on and off by the control IC so the gate drive losses become much more significant. Secondly, the output charge Q_{oss} and reverse recovery charge Q_{rr} both generate losses that are transfered to Q1 and increase the dissipation in that device. Thirdly, gate charge will impact the MOSFETs' susceptibility to Cdv/dt turn on.

The drain of Q2 is connected to the switching node of the converter and therefore sees transitions between ground and V_{in}. As Q1 turns on and off there is a rate of change of drain voltage dV/dt which is capacitively coupled to the gate of Q2 and can induce a voltage spike on the gate that is sufficient to turn the MOSFET on, resulting in shoot-through current . The ratio of Q_{gd}/Q_{gs1} must be minimized to reduce the potential for Cdv/dt turn on.

Spice model for IRF7807V can be downloaded in machine readable format at www.irf.com.

$$C_{oss} = C_{dg} + C_{ds}$$
$$\Delta Q_{oss} = C_{oss} \times \Delta V_{in}$$
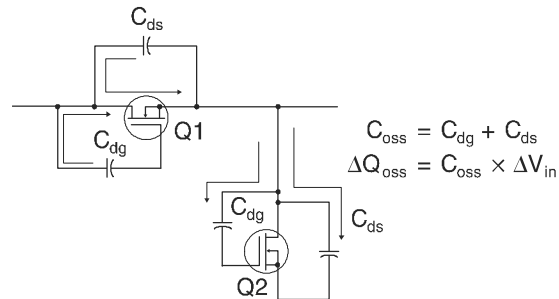
Figure 2: Q_{oss} Characteristic

Typical Mobile PC Application

The performance of these new devices has been tested in circuit and correlates well with performance predictions generated by the system models. An advantage of this new technology platform is that the MOSFETs it produces are suitable for both control FET and synchronous FET applications. This has been demonstrated with the 3.3V and 5V converters. (Fig 3 and Fig 4). In these applications the same MOSFET IRF7807V was used for both the control FET (Q1) and the synchronous FET (Q2). This provides a highly effective cost/performance solution.
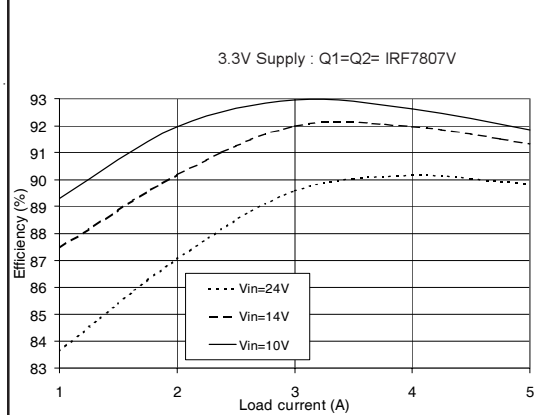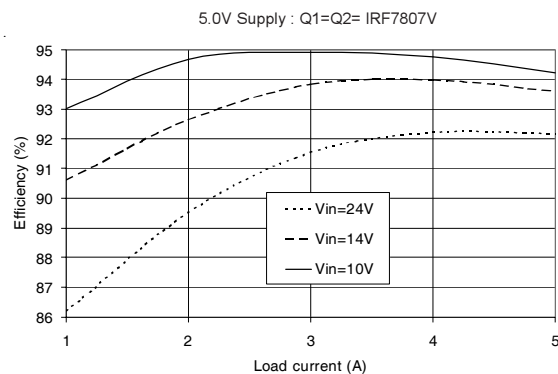
3.3V Supply : Q1=Q2= IRF7807V
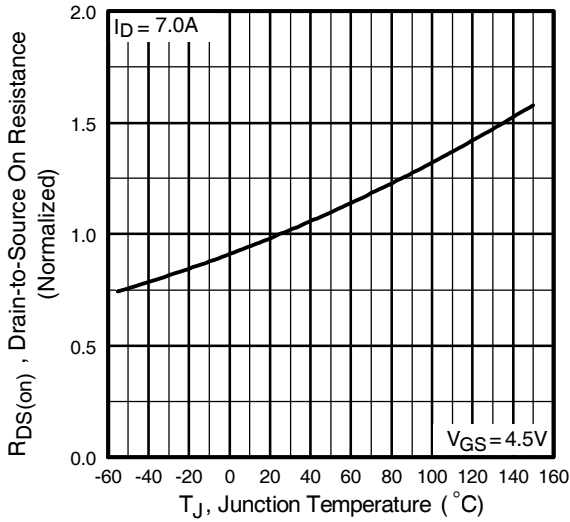
Efficiency (%)

Load current (A)

Vin=24V
Vin=14V
Vin=10V

Figure 3

5.0V Supply : Q1=Q2= IRF7807V

Efficiency (%)

Load current (A)

Vin=24V
Vin=14V
Vin=10V

Figure 4

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Fig 5. Normalized On-Resistance Vs. Temperature
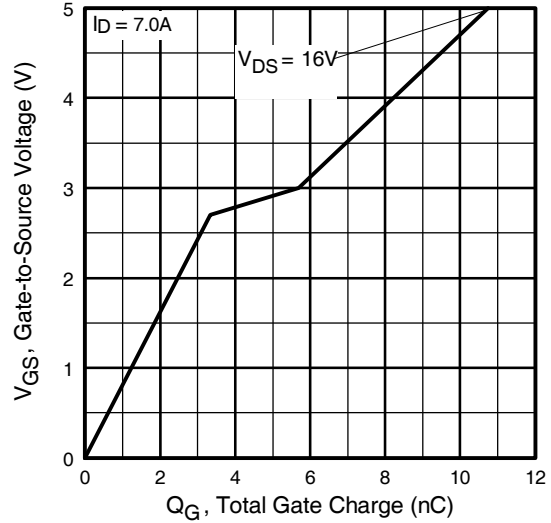

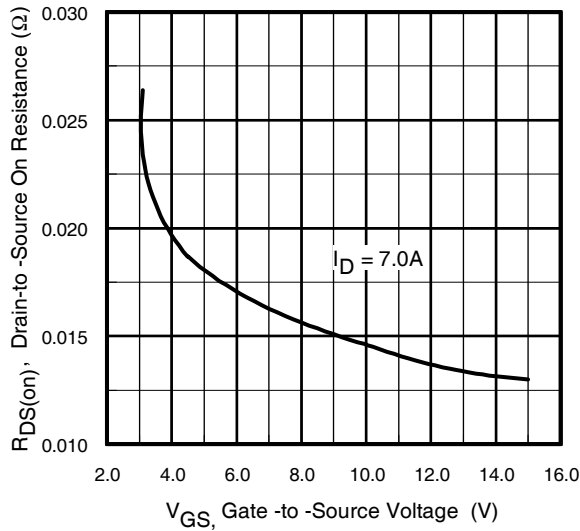**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage
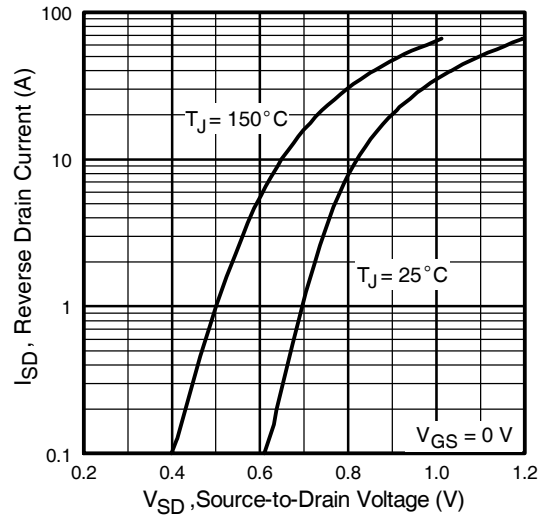

Fig 7. On-Resistance Vs. Gate Voltage

Fig 8. Typical Source-Drain Diode Forward Voltage
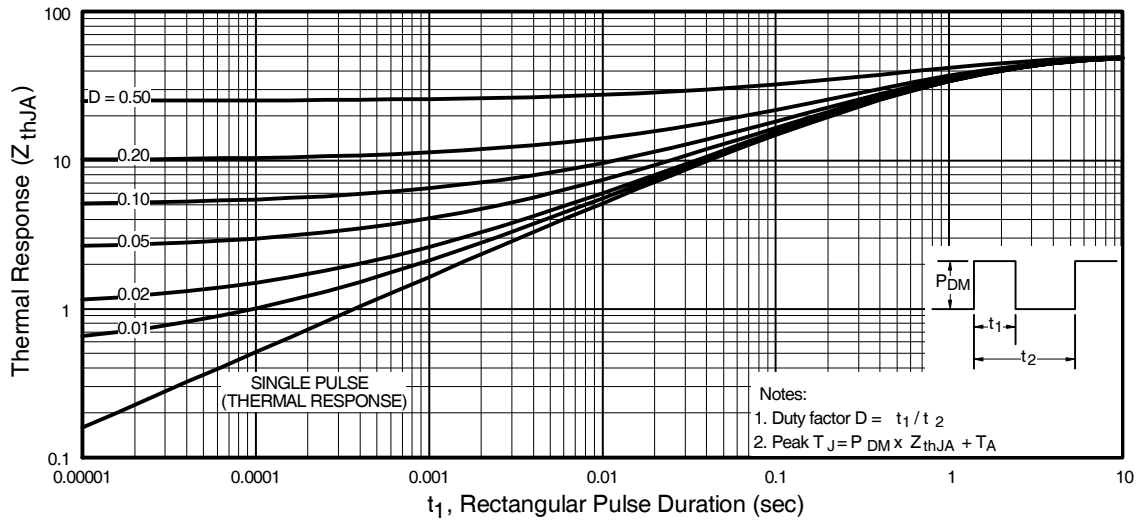
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Figure 9. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

International **IQR** Rectifier

SO-8 Package Outline

Dimensions are shown in milimeters (inches)
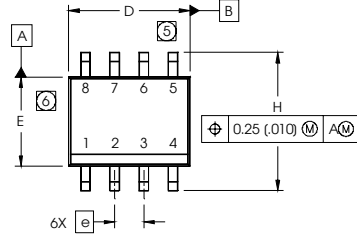
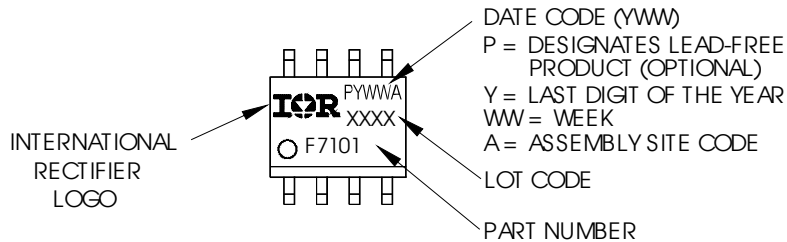| DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°
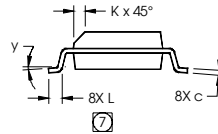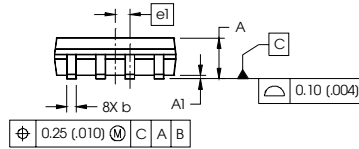
NOTES:
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

FOOTPRINT

8X 0.72 (.028)

6.46 (.255)

3X 1.27 (.050)

8X 1.78 (.070)
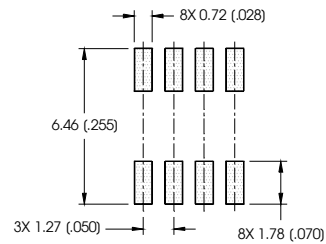
SO-8 Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

DATE CODE (YWW)
P = DESIGNATES LEAD-FREE PRODUCT (OPTIONAL)
Y = LAST DIGIT OF THE YEAR
WW = WEEK
A = ASSEMBLY SITE CODE

INTERNATIONAL RECTIFIER LOGO

LOT CODE

PART NUMBER

7

SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)

TERMINAL NUMBER 1

12.3 (.484)
11.7 (.461)

8.1 (.318)
7.9 (.312)

FEED DIRECTION
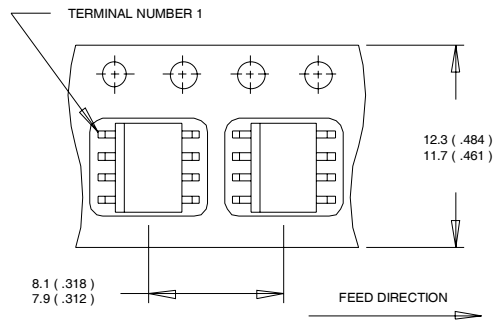
NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.

∅ 330.00
(12.992)
MAX.

14.40 (.566)
12.40 (.488)
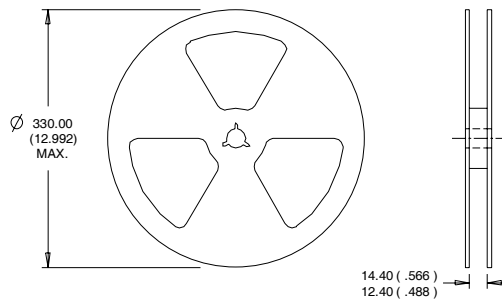
NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.
This product has been designed and qualified for the Consumer market.
Qualification Standards can be found on IR's Web site.

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